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(54) ELASTIC WAVE DEVICE

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(57)ABSTRACT

An elastic wave device includes an interdigital transducer electrode, a dielectric film, and a frequency adjustment film are disposed on a LiNbO₃ substrate. When Euler Angles of the LiNbO₃ substrate are within a range of about 0°±5°, within a range of about $\theta \pm 1.5^{\circ}$, within a range of about 0°±10°, the interdigital transducer electrode includes a main electrode, a film thickness of the main electrode normalized by a wavelength determined in accordance with an electrode finger pitch of the interdigital transducer electrode is denoted as T, and a density ratio of a material of the main electrode to Pt is denoted as r, the film thickness of the main electrode and θ of the Euler Angles satisfy $\theta = -0.05^{\circ}/(T/r 0.04)+31.35^{\circ}$.

